

Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. 294975US2PCT		SERIAL NO. 10/589,729	
<div style="border: 2px solid black; border-radius: 50%; padding: 10px; display: inline-block;"> OIP E NOV 17 2006 PATENT & TRADEMARK OFFICE </div>				APPLICANT Kazuhiro OHTSUKI, et al.			
				FILING DATE August 17, 2006		GROUP	
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
	AA						
	AB						
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION		
					YES	NO	
	AK	JP 2002-55899	02/20/2002	JAPAN (with English Abstract)		X	
	AL	JP 2000-353044	12/19/2000	JAPAN (with English Abstract)		X	
	AM	JP 2003-141143	05/16/2003	JAPAN (with English Abstract)		X	
	AN	JP 10-207908	08/07/1998	JAPAN (with English Abstract)		X	
	AO	JP 10-83241	03/31/1998	JAPAN (with English Abstract)		X	
	AP	JP 2002-324020	11/08/2002	JAPAN (with English Abstract)		X	
	AQ	JP 2001-175721	06/29/2001	JAPAN (with English Abstract)		X	
	AR	JP 2001-84202	03/30/2001	JAPAN (with English Abstract)		X	
	AS	JP 2001-73446	03/21/2001	JAPAN		X	
	AT	JP 2001-297043	10/26/2001	JAPAN (with English Abstract)		X	
	AU	JP 2001-243148	09/07/2001	JAPAN		X	
	AV						
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
	AW						
	AX						
	AY						
	AZ					<input type="checkbox"/> Additional References sheet(s) attached	
Examiner				/Michael Mapa/		Date Considered 08/25/2008	
<small>*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.</small>							

ALL REFERENCES CONSIDERED EXCEPT WHERE LINED THROUGH. /M.M./